INTEGRATED CIRCUITS



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Philips Semiconductors





Digital equalization for the tape drive processing of the DCC system

FEATURES

- Analog-to-digital conversion, demultiplexing, equalization and zero crossing of time multiplexed analog read amplifier signal
- Microcontroller interface
- Search mode envelope, label and virgin detection of the AUX channel
- · Search mode tape speed measurement
- Simplified external biassing
- Reduced power consumption
- Analog eye output
- 4 V nominal operating voltage capability.

ORDERING INFORMATION



GENERAL DESCRIPTION

Performing the Digital Equalizing function in the Digital Compact Cassette (DCC) system, the SAA2032 is intended for use in conjunction with the SAA2022, read amplifier TDA1317 or TDA1318.

EXTENDED TYPE	PACKAGE				
NUMBER	PINS	PIN POSITION	MATERIAL	CODE	
SAA2032GP	44	QFP 1	plastic	SOT205AG	

Note

1. When using reflow soldering it is recommended that the Dry Packing instructions in the *Quality Reference Pocketbook* are followed. The pocketbook can be ordered using the code 9398 510 34011.

Digital equalization for the tape drive processing of the DCC system

VDDAD VDD 11 12 3 RDCLK CLOCK GENERATION 43 f24 2 RDSYNC 37 LABEL VIRGIN LABEL DETECTOR SAA2032 36 VIRGIN 38 AENV 22 CH0 23 CH1 24 CH2 25 CH3 5 26 VIN ADC DEMUX FILTER SLICER CH4 27 CH5 28 CH6 29 CH7 30 AUX DIGEYE 44 VAL 15 DAC ANEYE 32 LTENDEQ 33 LTCNT1 LT INTERFACE 31 ► LTDATA 34 LTCNT0 35 LTCLK 13, 17, 39 8, 14 10 MEA663 777 VSSA VSSAD Vss Fig.1 Block diagram.

PINNING

SYMBOL	PIN	DESCRIPTION
DIGEYE	1	serial data output for eye pattern
RDSYNC	2	SYNC data for Read Amplifier (push-pull output)
RDCLK	3	data clock for Read Amplifier (push-pull output)
TEST1	4	test 1; to be connected to V _{ss}
VIN	5	analog time multiplexed input from Read Amplifier
REFN	6	lower reference voltage (+1 V) for ADC
REFP	7	upper reference voltage (+3.1 V) for ADC
V _{SSA}	8	analog ground (0 V)
BIASA	9	bias current for ADC (sinks current from V_{DDAD} via 33 k Ω)
V _{SSAD}	10	supply ground (0 V) for ADC
V _{DDAD}	11	supply voltage (+5 V) for ADC
V _{DD}	12	supply voltage (+5 V)
V _{SS}	13	supply ground (0 V)
V _{SSA}	14	supply ground (0 V)
ANEYE	15	analog eye voltage output
n.c.	16	not connected
V _{ss}	17	supply ground (0 V)
TEST4	18	test 4; do not connect
TEST5	19	test 5; do not connect
TEST6	20	test 6; do not connect
TEST7	21	test 7; do not connect
CH0	22	channel 0 output for SAA2022 (DCC Drive Signal Processing) (push-pull output)
CH1	23	channel 1 output for SAA2022 (push-pull output)
CH2	24	channel 2 output for SAA2022 (push-pull output)
СНЗ	25	channel 3 output for SAA2022 (push-pull output)
CH4	26	channel 4 output for SAA2022 (push-pull output)
CH5	27	channel 5 output for SAA2022 (push-pull output)
CH6	28	channel 6 output for SAA2022 (push-pull output)
CH7	29	channel 7 output for SAA2022 (push-pull output)
AUX	30	AUX channel output for SAA2022 (push-pull output)
LTDATA	31	microcontroller I/O data interface (3-state push-pull output and input; CMOS levels)
LTENDEQ	32	microcontroller interface enabling (CMOS input levels)
LTCNT1	33	microcontroller interface; mode control 1 (CMOS input levels)
LTCNT0	34	microcontroller interface; mode control 0 (CMOS input levels)
LTCLK	35	microcontroller bit-clock interface (CMOS input levels)
VIRGIN	36	search mode virgin detection output
LABEL	37	search mode label detection output
AENV	38	search mode auxiliary detection output
V _{SS}	39	supply ground (0 V)

SYMBOL	PIN	DESCRIPTION	
TEST8	40	test 8 input; to be connected to V _{SS}	
TEST9	41	test 9 input; to be connected to V _{SS}	
TEST10	42	test 10 input; to be connected to V _{ss}	
f24	43	clock input; typical frequency 24.576 MHz (CMOS input)	
VAL	44	synchronization output for DIGEYE	





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Digital equalization for the tape drive processing of the DCC system

FUNCTIONAL DESCRIPTION

Operating Modes

DEQ operating modes are programmed via the LT interface:

NORMAL

- A/D conversion
- Demultiplexing
- Equalization
- Zero crossing.

in this mode the SAA2032 performs the equalization and slicing of the eight data channels and the auxiliary channel. The eight data channels have a bit-rate of 96 kbits/s while the auxiliary channel has a bit-rate of 12 kbits/s.

The SAA2032 input is a time-multiplexed analog signal from the Read Amplifier. The signal contains ten time slots, of which nine are used. The Read Amplifier and the SAA2032 synchronize with the RDCLK and RDSYNC signals generated by the SAA2032.

Following A/D conversion and demultiplexing the nine channels are equalized. The encoding of the equalizing coefficients (12 per channel) are not fixed and must be loaded via the LT interface before operation.

The nine equalized output signals are up-sampled by a factor of 10 with the resulting signals fed to the slicer. The slicer output is applied to the SAA2022.

TEST

- A/D conversion
- Demultiplexing
- Equalization
- Zero crossing
- Eye-pattern.

Same as normal mode. In addition the digital and analog eye-pattern outputs are enabled. The eye-pattern output corresponds to one of the equalized channel outputs.

SEARCH

- A/D conversion
- Envelope detection
- Tape search and speed measurement.

In the search mode the analog input signal from the Read Amplifier is not the multiplexed signal but only the auxiliary channel signal. Following A/D conversion the envelope of this signal is filtered and sliced. This forms the Alternating Envelope AENV output. The LABEL and VIRGIN outputs are detected from this and the tape search speed measured.

Off

In the OFF mode the RDSYNC and RDCLK signals are HIGH, the EYE outputs are disabled and the channel and auxiliary outputs (CH0 to CH7 and AUX) are 3-stated.

Read Amplifier interface

The interface between the Read Amplifier and the SAA2032 consists of three signals:

- 1. VIN from Read Amplifier to SAA2032; time multiplexed data.
- RDSYNC from SAA2032 to Read Amplifier; synchronization between Read Amplifier multiplexer and SAA2032 demultiplexer.
- 3. RDCLK from SAA2032 to Read Amplifier; data clock for Read Amplifier multiplexer.

The multiplexed VIN output of the Read Amplifier changes to another channel at the rising edge of RDCLK. RDSYNC synchronizes the Read Amplifier VIN output: if RDSYNC is HIGH, the rising edge of the RDCLK will select the AUX channel.

Figures 4 and 5 show the relationship between the SAA2032 and the Read Amplifier.

SAA2022 interface

The interface with the SAA2022 consists of the 9 data output signals CH0 to CH7, AUX.

Table 1Dependency of Read Amplifier on
operational mode.

OPERATIONAL MODE	RDSYNC	RDCLK
Normal	YES	YES
Test	YES	YES
Search	HIGH	YES
Off	HIGH	HIGH

Label and virgin detection interface

When the DCC player is in its search mode, the tape is fast-wound while the head retains tape contact. The SAA2032 can be made to operate in the search mode and the information will be read from the auxiliary tape track.

The following three signals are generated:

- 1. LABEL: label detection (HIGH if label is detected).
- 2. VIRGIN: virgin tape detection (HIGH if virgin tape is detected).
- 3. AENV: alternating envelope (sliced envelope).

AENV, LABEL and VIRGIN are disabled in normal or off modes. LABEL, VIRGIN and AENV are LOW.

AENV, LABEL and VIRGIN are enabled when the SAA2032 is in search mode.

The device detects the envelope AENV of the auxiliary track at search speeds between 3 and 50 times normal speed. If AENV is continuously HIGH (label detection), LABEL will be HIGH.

When AENV is continuously LOW (virgin tape detection) VIRGIN will be HIGH.

Figures 6, 7 and 8 show the relationship between AENV, VIRGIN and LABEL.

Labelled tape-speed calculation

When the DCC player is in its search mode, the tape speed increases. LABEL information is encoded throughout its length. To examine the length of a label, the tape speed must be known. In search mode the SAA2032 assesses the speed of labelled tapes. The microcontroller obtains this information via the LT-interface.

The speed information is encoded in 3 variables:

- 1. SVF Speed Validation Flag (HIGH if invalid).
- 2. SC (4..0) Speed counter.
- 3. SR (1..0) Speed Range.

Search speed = $2^{SR} \times \frac{51.2}{SC}$ x normal speed. If SC = 0 then search speed > 51.2.

With SR = 0, 1, 2 or 3 and SC = 0 to 31.

If SVF = 1 then SR and SC values are invalid.

Appendix 1 gives a table of the search mode speed control.

Microcontroller (LT) Interface

The SAA2032 is able to exchange information with the microcontroller via the LT-interface. The microcontroller performs as master, the SAA2032 as slave.

Figure 9 gives the operation of the LT-interface.

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 $t_{d5} = t_{d6}$ = between 4 and 12 auxiliary blocks.





LTCNT specification

 Table 2
 Four types of data exchange performed on the interface.

LTCNT1	LTCNT0	LT DATA EXCHANGE MODE	FROM	то
0	0	data w	rrite μC	DEQ
0	1	data re	ead DEQ	μC
1	0	address w	rrite μC	DEQ
1	1	mode settings w	rite μC	DEQ

Mode Settings Load (LTCNT = 11) (See Fig.10)

The 8-bits transmitted under 'mode settings load' control both the 'operation mode' and the 'data exchange type'.

 Table 3
 Mode settings; 'operation mode'.

a1	a0	OPERATION MODE
0	0	normal
0	1	test
1	0	search
1	1	off

 Table 4
 Mode settings; 'data exchange type'.

b1	b0	DATA EXCHANGE		TYPE
0	0	write	coefficient	data
0	1	read	coefficient	data
1	1	read	envelope	data

Remark post condition: after every communication sequence the data exchange type must be set to "read coefficient data".



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Address Information Load (LTCNT = 10) (See Fig.11)

A channel/tap combination can be selected through this type of data exchange.

Co-efficient Data Load (LTCNT = 00) (See Fig.12)

This type of data exchange will overwrite the equalizer tap coefficient of the **current selected** channel/tap combination.

The coefficient data for tap <0000> of the auxiliary channel should always be zero.

Data Read (LTCNT = 01) (See Fig.13)

This type of data exchange will send information from the LTDATA register in the SAA2032 to the microcontroller. Data in the LTDATA register depends upon the current data exchange type.

LTDATA interpretation:

- · coefficient data: two's complement coefficient data
- tape speed data
 - d7 = SVF flag
 - d6 to d2 = SC4 to SC0
 - d1, d0 = SR1, SR0.

Tape speed data format is shown in Fig.14.



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Eye pattern output

To test equalization performance it is possible to output the equalized channels. For this purpose one analog and two digital output signals are provided. Selection of the EYE pattern output is determined by the last channel address sent to the SAA2032.

- DIGEYE: serial data line for 8-bits output value
- VAL: validation signal for data bits
- ANEYE: analog eye voltage output.

The eye outputs are enabled in test mode.

Table 5Eye outputs.

OPERATION MODE	DIGEYE	ANEYE
Normal	LOW	HIGH
Test	ENABLED	ENABLED
Search	LOW	HIGH
Off	LOW	HIGH

The internal number representation in the SAA2032 is in two's complement. The format of the selected 8-bits will be converted to the off-set-binary format. This means that the MSB of the two's complement number has been inverted. This 8-bit number is shifted out via the DIGEYE output.

Figure 17 gives the eye pattern output timing.



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LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V _{DD}	supply voltage		-0.5	+6.5	V
V	input voltage	note 1	-0.5	V _{DD} + 0.5	V
I _{SS}	supply current in V _{SS}		-	-100	mA
I _{DD}	supply current in V _{DD}		-	100	mA
I,	input current		-10	10	mA
I _o	output current		-20	20	mA
P _{tot}	total power dissipation		-	550	mW
T _{stg}	storage temperature		-55	+150	°C
T _{amb}	operating ambient temperature		-40	+85	°C
V _{es1}	electrostatic handling	note 2	-1500	+1500	V
V _{es2}	electrostatic handling	note 3	-70	+70	V

Notes

- 1. Input voltage should not exceed 6.5 V unless otherwise specified.
- 2. Equivalent to discharging a 100 pF capacitor through a 1.5 k $\!\Omega$ series resistor.
- 3. Equivalent to discharging a 200 pF capacitor through a 0 Ω series resistor.

DC CHARACTERISTICS

 V_{DD} = 3.8 to 5.5 V; T_{amb} = -40 to +85 °C; unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
Supply		1	I	1	1	
V _{DD}	supply voltage		3.8	5.0	5.5	V
V _{DDAD}	supply voltage for ADC	note 1	3.8	5.0	5.5	V
I _{DD}	supply current	$V_{DD} = 5 V$; note 2	_	22	26	mA
		V _{DD} = 3.8 V; note 2	_	12	14	mA
I _{DDAD}	supply current for ADC	$V_{DDAD} = 5 V$	_	11	13	mA
		V _{DDAD} = 3.8 V	_	5	7	mA
I _{OP}	operating current	note 3	1.3	1.9	3.4	mA
Inputs f24, LTCL	K, LTCNT0, LTCNT1 and LTEN	NDEQ				
V _{IL}	LOW level input voltage		0	-	0.3V _{DD}	V
V _{IH}	HIGH level input voltage		0.7V _{DD}	_	V _{DD}	V
I _I	input current	$V_{I} = 0 V; T_{amb} = 25 °C$	_	_	-10	μA
		$V_{I} = V_{DD}; T_{amb} = 25 \circ C$	_	_	10	μA
Input REFP						
V _{refp}	reference voltage		2.7	3.1	3.4	V
Input REFN		·	·	·	•	
V _{refn}	reference voltage		0.7	1.0	1.4	V

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SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
Inputs REFP and	REFN	1		1		-
ΔV_{ref}	reference voltage difference between REFP and REFN		2	2.1	2.7	V
Input VIN		•		•	·	
V _{I(p-p)}	input voltage (peak-to-peak)		V _{refn}	_	V _{refp}	V
I _I	input current		_	_	100	μA
Digital outputs		·			·	-
V _{OL}	LOW level output voltage	note 4	_	_	0.4	V
V _{OH}	HIGH level output voltage	note 4	$V_{DD} - 0.5$	-	-	V
Output ANEYE						•
Vo	output voltage	note 4	_	-	V _{DDAD}	V
Vo	output voltage range	note 4	_	1.1	-	V
Input/output LTD	ATA	·			·	
V _{OL}	LOW level output voltage	$I_0 = -3 \text{ mA}$	_	_	0.4	V
V _{OH}	HIGH level output voltage	l _o = 2 mA	V _{DD} - 0.5	-	-	V
I _{oz}	leakage current with outputs	$V_{I} = 0 V; T_{amb} = 25 °C$	_	_	10	μA
	in 3-state	$V_{I} = V_{DD}; T_{amb} = 25 \circ C$	_	_	10	μA
V _{IL}	LOW level input voltage		_	-	0.3V _{DD}	V
V _{IH}	HIGH level input voltage		0.7V _{DD}	-	-	V

Notes

1. V_{DDAD} should never be lower than $V_{\text{DD}}-0.2$ V.

2. For load impedances in a typical application circuit.

3. Operating reference current for the specified range of V_{refp} allowing for the tolerance on the internal resistor.

4. For outputs DIGEYE, RDSYNC, RDCLK, CH0 to CH7, AUX and VAL the maximum load current is 1 mA. For ANEYE output the maximum load current is 10 μA. For VIRGIN, LABEL and AENV the maximum load current is 2 mA.

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AC CHARACTERISTICS

 V_{DD} = 3.8 to 5.5 V; T_{amb} = –40 to 85 °C; unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
VIN		1	1	-	-	
C _i	input capacitance		-	-	15	pF
All digital inp	outs		·	·	•	
C _i	input capacitance		_	_	10	pF
Clock input f	24		•			
f	clock frequency		23	24.576	26	MHz
t _p	pulse width LOW or HIGH		10	-	-	ns
	K, LTENDEQ, LTCNT0 and LTCN	T1	·	ŀ	·	
t _{su}	set-up time to f24	note 1	10	-	-	ns
t _h	hold time from f24	note 1	30	-	-	ns
All outputs		•	·	•	·	
C _i	input capacitance		-	-	10	pF
CL	load capacitance		-	-	50	pF
t _d	propagation delay time from f24	note 1	-	-	80	ns
Input/output	LTDATA	•				
C _i	input capacitance		-	-	10	pF
CL	load capacitance		-	-	50	pF
t _d	propagation delay time from f24		-	-	80	ns
t _{su}	set-up time to f24	note 1	10	-	-	ns
t _h	hold time from f24	note 1	30	-	-	ns

Note

1. LOW-to-HIGH transition.

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CONVERTER CHARACTERISTICS

V_{DD} = 3.8 to 5.5 V; T_{amb} = -40 to 85 °C; unless otherwise	specified.
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SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
Analog-to-D	igital Converter; VIN	1		- I	-	-
	resolution		-	7	-	bits
	conversation data available after		-	$2 \times t_{cy}$	_	
	effective input bandwidth	6-bit resolution at f _s = 3.1 MHz	0.5	-	-	MHz
	differential non-linearity		-	-	±0.99	LSB
V _{refn}	reference voltage at VREFN	note 1	0.7	1.0	1.4	V
V _{refp}	reference voltage at VREFP		2.7	3.1	3.4	V
ΔV_{ref}	reference voltage difference between REFP and REFN		2	2.1	2.7	V
V _i	input voltage		V _{refn}	-	V _{refp}	V
S+THD/N	signal-to-total harmonic distortion and noise ratio	note 2	21	-	-	dB
C _i	input capacitance		_	-	15	pF
I _I	input current (DC)	note 3	_	_	100	μA
Digital-to-an	alog converter; output ANEYE			•		
	resolution		-	6	-	bits
Vo	output voltage	note 4	-	-	V _{DDAD}	V
Vo	output voltage range	note 4	-	1.1	_	V

Notes

1. V_{refp} is supplied externally.

 V_{refn} is derived internally and set to ${\it V_3V_{refp}}.$ V_{refn} must be decoupled externally at pin 6 via a 100 nF capacitor.

- 2. Signal level (f_s) –20 dB, at any DC level within the input voltage range.
- 3. The output impedance of the analog input signal source must be <150 Ω .
- 4. Load impedance $\geq 1 \text{ M}\Omega$.

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APPENDIX 1

Search Mode Speed Control Interface

In search mode the SAA2032 measures the tape speed. The tape speed is encapsulated in the variables:

- SVF Speed Validation Flag; is HIGH if NOT valid
- SC Speed Counter
- SR Speed Range.

The values in Table 6 represent the speed in multiples of the nominal tape speed of 4.76 cm/s.

Table 6	Speed in multiples of nominal tape speed.

SC[4 0]	SR[1 0]				REMARKS	
30[4 0]	0	1	2	3	REIWIARNS	
0	>51.20	>102.40	>204.80	>409.60		
1	51.20	102.40	204.80	409.60		
2	25.60	51.20	102.40	204.80		
3	17.07	34.13	68.27	136.53	abift to higher apped range	
4	12.80	25.60	51.20	102.40	shift to higher speed range	
5	10.24	20.48	40.96	81.92		
6	8.53	17.07	34.13	68.27		
7	7.31	14.63	29.26	58.51		
8	6.40	12.80	25.60	51.20		
9	5.69	11.38	22.76	45.51		
10	5.12	10.24	20.48	40.96		
11	4.65	9.31	18.62	37.24		
12	4.27	8.53	17.07	34.13		
13	3.94	7.88	15.75	31.51	- normal working area -	
14	3.66	7.31	14.63	29.26		
15	3.41	6.83	13.65	27.31		
16	3.20	6.40	12.80	25.60		
17	3.01	6.02	12.05	24.09		

8014 01	SR[1 0]				DEMARKS	
SC[4 0]	0	1	2	3	REMARKS	
18	2.84	5.69	11.38	22.76		
19	2.69	5.39	10.78	21.56		
20	2.56	5.12	10.24	20.48		
21	2.44	4.88	9.75	19.50		
22	2.33	4.65	9.31	18.62		
23	2.23	4.45	8.90	17.81		
24	2.13	4.27	8.53	17.07	abift to lower encod renge	
25	2.05	4.10	8.19	16.38	shift to lower speed range	
26	1.97	3.94	7.88	15.75		
27	1.90	3.79	7.59	15.17		
28	1.83	3.66	7.31	14.63		
29	1.77	3.53	7.06	14.12		
30	1.71	4.41	6.83	13.65		
31	1.65	3.30	6.61	13.21		

PACKAGE OUTLINE



Digital equalization for the tape drive processing of the DCC system

SOLDERING

Quad flat-packs

BY WAVE

During placement and before soldering, the component must be fixed with a droplet of adhesive. After curing the adhesive, the component can be soldered. The adhesive can be applied by screen printing, pin transfer or syringe dispensing.

Maximum permissible solder temperature is 260 $^{\circ}$ C, and maximum duration of package immersion in solder bath is 10 s, if allowed to cool to less than 150 $^{\circ}$ C within 6 s. Typical dwell time is 4 s at 250 $^{\circ}$ C.

A modified wave soldering technique is recommended using two waves (dual-wave), in which, in a turbulent wave with high upward pressure is followed by a smooth laminar wave. Using a mildly-activated flux eliminates the need for removal of corrosive residues in most applications.

BY SOLDER PASTE REFLOW

Reflow soldering requires the solder paste (a suspension of fine solder particles, flux and binding agent) to be applied to the substrate by screen printing, stencilling or pressure-syringe dispensing before device placement. Several techniques exist for reflowing; for example, thermal conduction by heated belt, infrared, and vapourphase reflow. Dwell times vary between 50 and 300 s according to method. Typical reflow temperatures range from 215 to 250 $^{\circ}$ C.

Preheating is necessary to dry the paste and evaporate the binding agent. Preheating duration: 45 min at 45 °C.

REPAIRING SOLDERED JOINTS (BY HAND-HELD SOLDERING IRON OR PULSE-HEATED SOLDER TOOL)

Fix the component by first soldering two, diagonally opposite, end pins. Apply the heating tool to the flat part of the pin only. Contact time must be limited to 10 s at up to $300 \,^{\circ}$ C. When using proper tools, all other pins can be soldered in one operation within 2 to 5 s at between 270 and 320 $^{\circ}$ C. (Pulse-heated soldering is not recommended for SO packages.)

For pulse-heated solder tool (resistance) soldering of VSO packages, solder is applied to the substrate by dipping or by an extra thick tin/lead plating before package placement.

DEFINITIONS

Data sheet status				
Objective specification	bjective specification This data sheet contains target or goal specifications for product development.			
Preliminary specification	This data sheet contains preliminary data; supplementary data may be published later.			
Product specification	This data sheet contains final product specifications.			
Limiting values				
Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress rating only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.				
Application information				
Where application information is given, it is advisory and does not form part of the specification.				

LIFE SUPPORT APPLICATIONS

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